

Notice of References Cited	Application/Control No. 10/521,594		Applicant(s)/Patent Under Reexamination IWASAKI ET AL.	
	Examiner EDMUND H. LEE		Art Unit 1791	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-4,239,727	12-1980	Myers et al.	264/550
*	B	US-4,388,356	06-1983	Hrivnak et al.	428/36.92
	C	US-			
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	F	US-			
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	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

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	N					
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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)			
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